## Notice of References Cited Application/Control No. 10/609,633 Applicant(s)/Patent Under Reexamination WISNIEWSKI ET AL. Examiner Khai M. Nguyen Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,445,919 B1	09-2002	Suonvieri, Jukka	455/424
*	В	US-2005/0278710 A1	12-2005	Lucas et al.	717/136
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	Т	US-			
	J	US-			
	К	US-		·	
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					'
	Т				1	

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.